


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/677,260	TANAKA ET AL.	
	Examiner	Art Unit	
	Thinh T. Nguyen	2818	

ISSUE CLASSIFICATION										
ORIGINAL				CROSS-REFERENCE(S)						
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
257	341			257	341	133				
INTERNATIONAL CLASSIFICATION										
H	0	1	L	29/76						
				/						
				/						
				/						
				/						
Thinh T. Nguyen 3/2005 (Assistant Examiner) (Date)				David Nelms Supervisory Patent Examiner Technology Center 2800 (Primary Examiner) (Date) 4/05				Total Claims Allowed: 20		
G. S. Stanley 4-14-05 (Legal Instruments Examiner) (Date)								O.G. Print Claim(s) 1	O.G. Print Fig. fig. 13	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
1	1	18	31	61	91	121	151	181	
2	2	19	32	62	92	122	152	182	
3	3	20	33	63	93	123	153	183	
4	4		34	64	94	124	154	184	
5	5		35	65	95	125	155	185	
6	6		36	66	96	126	156	186	
	7		37	67	97	127	157	187	
7	8		38	68	98	128	158	188	
	9		39	69	99	129	159	189	
	10		40	70	100	130	160	190	
	11		41	71	101	131	161	191	
	12		42	72	102	132	162	192	
	13		43	73	103	133	163	193	
	14		44	74	104	134	164	194	
	15		45	75	105	135	165	195	
	16		46	76	106	136	166	196	
	17		47	77	107	137	167	197	
	18		48	78	108	138	168	198	
	19		49	79	109	139	169	199	
	20		50	80	110	140	170	200	
8	21		51	81	111	141	171	201	
9	22		52	82	112	142	172	202	
10	23		53	83	113	143	173	203	
11	24		54	84	114	144	174	204	
12	25		55	85	115	145	175	205	
13	26		56	86	116	146	176	206	
14	27		57	87	117	147	177	207	
15	28		58	88	118	148	178	208	
16	29		59	89	119	149	179	209	
17	30		60	90	120	150	180	210	